



Test Report: EPS-65-5

65W Single Output Switching Power Supply

■ DESIGN VERIFY TEST

Output Function Test

Input Function Test

Protection Function Test

Component Stress Test

■ SAFETY & E.M.C. TEST

Safety Test

E.M.C. Test

■ RELIABILITY TEST

ENVIRONMENT TEST

DESIGN VERIFY TEST

OUTPUT FUNCTION TEST

NO	TEST ITEM	SPECIFICATION	TEST CONDITION	RESULT	VERDICT
1	RIPPLE & NOISE	V1 : 80 mVp-p (Max)	I/P : 230VAC O/P : FULL LOAD Ta : 25°C	V1 : 36 mVp-p (Max)	P
2	OUTPUT VOLTAGE ADJUST RANGE	CH1 : 4.75 V ~ 5.5 V	I/P : 230 VAC I/P : 115 VAC O/P : MIN LOAD Ta : 25°C	4.51 V ~ 5.71 V/ 230 VAC 4.51 V ~ 5.71 V/ 115 VAC	P
3	OUTPUT VOLTAGE TOLERANCE	V1 : -2 % ~ +2 % (Max)	I/P : 85 VAC / 264 VAC O/P : FULL / MIN LOAD Ta : 25°C	V1 : -0.01 % ~ 1.46 %	P
4	LINE REGULATION	V1 : -0.5 % ~ +0.5 % (Max)	I/P : 100VAC ~ 264 VAC O/P : FULL LOAD Ta : 25°C	V1 : -0.36 % ~ 0.87 %	P
5	LOAD REGULATION	V1 : -1 % ~ +1 % (Max)	I/P : 230 VAC O/P : FULL ~ MIN LOAD Ta : 25°C	V1 : -0.46+ % ~ 0.62 %	P
6	SET UP TIME	230VAC : 1000 ms (Max) 115VAC : 2000 ms(Max)	I/P : 230 VAC I/P : 115 VAC O/P : FULL LOAD Ta : 25°C	230VAC/ 608 ms 115VAC/ 902 ms	P
7	RISE TIME	230VAC : 50 ms (Max) 115VAC : 50 ms (Max)	I/P : 230 VAC I/P : 115 VAC O/P : FULL LOAD Ta : 25°C	230VAC/ 5.2 ms 115VAC/ 4.5 ms	P
8	HOLD UP TIME	230VAC : 50 ms (TYP) 115VAC : 12 ms (TYP)	I/P : 230 VAC I/P : 115 VAC O/P : FULL LOAD Ta : 25°C	230VAC/ 70 ms 115VAC/ 71 ms	P
9	OVER/UNDERSHOOT TEST	< ±10%	I/P : 230 VAC O/P : FULL LOAD Ta : 25°C	TEST : 2.8 %	P
10	DYNAMIC LOAD	V1 : 1000 mVp-p	I/P : 230 VAC (1).O/P : FULL /Min LOAD 90%DUTY/ 1KHZ (2).O/P : FULL /Min LOAD 90%DUTY/ 3KHZ (3).O/P : FULL /Min LOAD 90%DUTY/ 5KHZ (4).O/P : FULL /Min LOAD 50%DUTY/ 120HZ Ta : 25°C	(1) 616 mVp-p (2) 616 mVp-p (3) 636 mVp-p (4) 692 mVp-p	P

INPUT FUNCTION TEST

NO	TEST ITEM	SPECIFICATION	TEST CONDITION	RESULT	VERDICT
1	INPUT VOLTAGE RANGE	85VAC~264 VAC	I/P : TESTING O/P : FULL LOAD Ta : 25℃	59 V~264V	P
			I/P : LOW-LINE-3V= 82 V HIGH-LINE+15%=300 V O/P : FULL/MIN LOAD ON : 30 Sec . OFF : 30 Sec 10MIN (AC POWER ON/OFF NO DAMAGE)	TEST : OK	
2	INPUT FREQUENCY RANGE	47HZ ~63 HZ NO DAMAGE OSC	I/P : 85 VAC ~ 264 VAC O/P : FULL~MIN LOAD Ta : 25℃	TEST : OK	P
3	EFFICIENCY	82 % (TYP)	I/P : 230 VAC O/P : FULL LOAD Ta : 25℃	83.8 %	P
4	INPUT CURRENT	230V/ 1 A (TYP) 115V/ 1.8 A (TYP)	I/P : 230 VAC I/P : 115 VAC O/P : FULL LOAD Ta : 25℃	I = 0.65 A/ 230 VAC I = 1.03 A/ 115 VAC	P
5	INRUSH CURRENT	230V/ 60 A (TYP) COLD START	I/P : 230 VAC O/P : FULL LOAD Ta : 25℃	I = 39.2 A/ 230 VAC	P
6	LEAKAGE CURRENT	< 2 mA / 240 VAC	I/P : 264 VAC O/P : Min LOAD Ta : 25℃	L-FG : 0.76 mA N-FG : 0.71 mA	P
7	NO LOAD CONSUMPTION	< 0.3 W	I/P : 240VAC O/P : NO LOAD Ta : 25℃	< 0.239 W	P

PROTECTION FUNCTION TEST

NO	TEST ITEM	SPECIFICATION	TEST CONDITION	RESULT	VERDICT
1	OVER LOAD PROTECTION	115 % ~ 160 %	I/P : 230 VAC I/P : 115 VAC O/P : TESTING Ta : 25℃	141.6 %/ 230 VAC 134.1 %/ 115 VAC Hiccup Mode	P
2	OVER VOLTAGE PROTECTION	CH1 : 5.6 V ~ 6.75 V	I/P : 230 VAC I/P : 115 VAC O/P : MIN LOAD Ta : 25℃	6.31 V/ 230 VAC 6.33 V/ 115 VAC Shut down Re- power ON	P
3	SHORT PROTECTION	SHORT EVERY OUTPUT 1 HOUR NO DAMAGE	I/P : 264 VAC O/P : FULL LOAD Ta : 25℃	NO DAMAGE Hiccup Mode	P

COMPONENT STRESS TEST

NO	TEST ITEM	SPECIFICATION	TEST CONDITION	RESULT	VERDICT
1	Power Transistor (D to S) or (C to E) Peak Voltage	Q 1 Rated : 650 V 12 A	I/P : High-Line +3V = 267 V O/P : (1)Full Load Turn on (2) Output Short (3)Full load continue Ta : 25℃	(1) 606 V (2) 546 V (3) 507 V	P
2	Diode Peak Voltage	Q101 Rated : 40 V 160 A	I/P : High-Line +3V = 267 V O/P : (1)Full Load Turn on (2)Output Short (3)Full load continue Ta : 25℃	(1) 30.5 V (2) 27.4 V (3) 30.1 V	P
3	Clamp Diode Peak Voltage	D 1 Rated : 600 V 3 A	I/P : High-Line +3V = 267 V O/P : (1) Dynamic Load 90%Duty/1KHz (2)Full load continue Ta : 25℃	(1) 536 V (2) 506 V	P
4	Input Capacitor Voltage	C5 Rated : 100 u /400V/105℃	I/P : High-Line +3V = 267 V O/P : (1)Full Load Turn on /Off (2) Min load Turn on /Off (3)Full Load /Min load Change Ta : 25℃	(1) 394 V (2) 394 V (3) 394 V	P
5	Control IC Voltage Test	U1 Rated : 28 V	I/P : High-Line +3V = 267 V O/P : (1)Full Load Turn on /Off (2) Min load Turn on /Off (3)Full Load /Min load Change Ta : 25℃	(1) 22.9 V (2) 20.6 V (3) 23.1 V	P

■ SAFETY & E.M.C. TEST

SAFETY TEST

NO	TEST ITEM	SPECIFICATION	TEST CONDITION	RESULT	VERDICT
1	WITHSTAND VOLTAGE	I/P-O/P : 3 KVAC/min I/P-FG : 2.0 KVAC/min O/P-FG : 0.5 KVAC/min	I/P-O/P : 3.6 KVAC/min I/P-FG : 2.4 KVAC/min O/P-FG : 0.6 KVAC/min Ta : 25°C	I/P-O/P : 5.44 mA I/P-FG : 4.39 mA O/P-FG : 3.29 mA NO DAMAGE	P
2	ISOLATION RESISTANCE	I/P-O/P : 500VDC>100MΩ I/P-FG : 500VDC>100MΩ O/P-FG : 500VDC>100MΩ	I/P-O/P : 500 VDC I/P-FG : 500 VDC O/P-FG : 500 VDC Ta : 25°C/70%RH	I/P-O/P : 9999 MΩ I/P-FG : 9999 MΩ O/P-FG : 9999 MΩ NO DAMAGE	P
3	GROUNDING CONTINUITY	FG(PE) TO CHASSIS OR TRACE < 100 mΩ	40 A / 2min Ta : 25°C / 70%RH	3 mΩ	P

E.M.C TEST

NO	TEST ITEM	SPECIFICATION	TEST CONDITION	RESULT	VERDICT
1	HARMONIC	EN61000-3-2 CLASS A	I/P : 230 VAC/50HZ O/P : FULL LOAD Ta : 25°C	PASS	P
2	CONDUCTION	EN55022 CLASS B	I/P : 230 VAC (50HZ) O/P : FULL/50% LOAD Ta : 25°C	PASS Test by certified Lab	P
3	RADIATION	EN55022 CLASS B	I/P : 230 VAC (50HZ) O/P : FULL LOAD Ta : 25°C	PASS Test by certified Lab	P
4	E.S.D	EN61000-4-2 INDUSTRY AIR : 8KV / Contact : 4KV	I/P : 230 VAC/50HZ O/P : FULL LOAD Ta : 25°C	CRITERIA A	P
5	E.F.T	EN61000-4-4 INDUSTRY INPUT : 2KV	I/P : 230 VAC/50HZ O/P : FULL LOAD Ta : 25°C	CRITERIA A	P
6	SURGE	IEC61000-4-5 INDUSTRY L-N : 2KV L,N-PE : 4KV	I/P : 230 VAC/50HZ O/P : FULL LOAD Ta : 25°C	CRITERIA A	P
7	Test by certified Lab & Test Report Prepare				

ENVIRONMENT TEST

NO	TEST ITEM	SPECIFICATION	TEST CONDITION	RESULT	VERDICT																																																												
1	TEMPERATURE RISE TEST	MODEL : EPS-65-5 PCB ONLY 1. ROOM AMBIENT BURN-IN : 2 HRS I/P : 230VAC O/P : FULL LOAD Ta=33.7 °C 2. HIGH AMBIENT BURN-IN : 2 HRS I/P : 230VAC O/P : FULL LOAD Ta= 39.9°C <table><tr><th>NO</th><th>Position</th><th>PART NUMBER</th><th>ROOM AMBIENT Ta= 33.7°C</th><th>HIGH AMBIENT Ta= 39.9°C</th></tr><tr><td>1</td><td>LF1</td><td>TR732-R5 T(9×5×3) 1.41m RPT-75C</td><td>76.8°C</td><td>83.9°C</td></tr><tr><td>2</td><td>BD1</td><td>BD 4A/800V GLASS GBU408</td><td>75.1°C</td><td>81.4°C</td></tr><tr><td>3</td><td>C5</td><td>C/E 100u/400V 105°C 18*25 KMG</td><td>68.2°C</td><td>74.1°C</td></tr><tr><td>4</td><td>D1</td><td>RD 3A/600V 1N5406 DO-201 T-52mm</td><td>100.0°C</td><td>105.8°C</td></tr><tr><td>5</td><td>R42</td><td>R/NW 2W 0.22Ω 5%</td><td>87.5°C</td><td>92.6°C</td></tr><tr><td>6</td><td>Q1</td><td>FET STF14NM65N 12A/650V TO220F</td><td>98.7°C</td><td>104.3°C</td></tr><tr><td>7</td><td>T1</td><td>MT TF5085-R2 EER-28 EPS-65-5 B</td><td>88.0°C</td><td>93.8°C</td></tr><tr><td>8</td><td>U1</td><td>PWM NCP1380BDR2G SO-8</td><td>98.7°C</td><td>103.5°C</td></tr><tr><td>9</td><td>U100</td><td>CONTROL TEA1791T SO8</td><td>90.2°C</td><td>97.8°C</td></tr><tr><td>10</td><td>Q101</td><td>FET AP9963GP 160A/40V TO220</td><td>91.3°C</td><td>100.8°C</td></tr><tr><td>11</td><td>C105</td><td>C/E 2200u/10V UL10Kh 10*25 KZM</td><td>75.6°C</td><td>83.5°C</td></tr></table>			NO	Position	PART NUMBER	ROOM AMBIENT Ta= 33.7°C	HIGH AMBIENT Ta= 39.9°C	1	LF1	TR732-R5 T(9×5×3) 1.41m RPT-75C	76.8°C	83.9°C	2	BD1	BD 4A/800V GLASS GBU408	75.1°C	81.4°C	3	C5	C/E 100u/400V 105°C 18*25 KMG	68.2°C	74.1°C	4	D1	RD 3A/600V 1N5406 DO-201 T-52mm	100.0°C	105.8°C	5	R42	R/NW 2W 0.22Ω 5%	87.5°C	92.6°C	6	Q1	FET STF14NM65N 12A/650V TO220F	98.7°C	104.3°C	7	T1	MT TF5085-R2 EER-28 EPS-65-5 B	88.0°C	93.8°C	8	U1	PWM NCP1380BDR2G SO-8	98.7°C	103.5°C	9	U100	CONTROL TEA1791T SO8	90.2°C	97.8°C	10	Q101	FET AP9963GP 160A/40V TO220	91.3°C	100.8°C	11	C105	C/E 2200u/10V UL10Kh 10*25 KZM	75.6°C	83.5°C	P
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2	OVER LOAD BURN-IN TEST	NO DAMAGE 1 HOUR (MIN)	I/P : 230 VAC O/P : 126 % LOAD Ta : 25°C	TEST : OK	P																																																												
3	LOW TEMPERATURE TURN ON TEST	TURN ON AFTER 2 HOUR	I/P : 264VAC/100VAC O/P : 100 % LOAD Ta= -30 °C	TEST : OK	P																																																												
4	HIGH HUMIDITY HIGH TEMPERATURE HIGH VOLTAGE TURN ON TEST	AFTER 12 HOURS IN CHAMBER ON CONTROL 40 °C NO DAMAGE	I/P : 272 VAC O/P : FULL LOAD Ta= 40 °C HUMIDITY= 95 %R.H	TEST : OK	P																																																												
5	TEMPERATURE COEFFICIENT	± 0.03 %/°C (0~50°C)	I/P : 230 VAC O/P : FULL LOAD	± 0.013 %/°C (0~50°C)	P																																																												
6	STORAGE TEMPERATURE TEST	1. Thermal shock Temperature : -40°C~ +85°C 2. Temperature change rate : 25°C / MIN 3. Dwell time low and high temperature : 30 MIN/EACH 4. Total test cycle : 5 CYCLE 5. Input/Output condition : STATIC		OK	P																																																												

7	THERMAL SHOCK TEST	1. Thermal shock Temperature : -30°C ~ +70°C 2. Temperature change rate : 25°C / MIN 3. Dwell time low and high temperature : 30 MIN/EACH 4. Total test cycle : 10 CYCLE 5. Input/Output condition : 230VAC/Full Load AC ON/OFF TEST turn on 58sec ; turn off 2sec	OK	P
8	VIBRATION TEST	1 Carton & 1 Set (1) Waveform : Sine Wave (2) Frequency : 10~500Hz (3) Sweep Time : 12min/sweep cycle (4) Acceleration : 2G (5) Test Time : 60min in each axis (X.Y.Z) (6) Ta : 25°C	TEST : OK	P
9	CAPACITOR LIFE CYCLE	EPS-65-5 PCB ONLY SUPPOSE C 105 IS THE MOST CRITICAL COMPONENT (1) I/P : 230VAC O/P : FULL LOAD Ta= 25 °C LIFE TIME (2) I/P : 230VAC O/P : FULL LOAD Ta=40 °C LIFE TIME (3) I/P : 230VAC O/P : 75% LOAD Ta= 40 °C LIFE TIME (4) I/P : 230VAC O/P : 50% LOAD Ta= 40 °C LIFE TIME	(1) 148297 HRS (2) 47247 HRS (3) 60671 HRS (4) 147240 HRS	P
10	MTBF	MIL-HDBK-217F NOTICE S2 PARTS COUNT TOTAL FAILURE RATE : 563 KHR		P
11	DMTBF/Accelerated Life Test	Demonstration Mean Time Between Failure (Expected Life): Above 30,000 hours @ TA 40°C		P

DATE	SAMPLE	TEST RESULT	TESTER	APPROVAL
2011.7.18	RD SAMPLE	PASS	Shenym	Wangdz
Y1201C659	PRODUCT SAMPLE	PASS	Shenym	Wangdz

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